

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination WANG ET AL.	
		10/665,204	Examiner	Art Unit A. Sefer 2826

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	C	US-5,800,630	09-1998	Vilela et al.	136/249
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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